


<b>Search Notes</b>  	<b>Application/Control No.</b>  10549559	<b>Applicant(s)/Patent Under Reexamination</b>  LE PHAN, KIM
	<b>Examiner</b>  HARRY W BYRNE	<b>Art Unit</b>  2824

SEARCHED			
Class	Subclass	Date	Examiner
365	158, 171, 173, 189.01, 189.04, 189.14, 230.04, 243	3/1/2008	HWB
711	200, 202, 217, 218, 220	3/1/2008	HWB

SEARCH NOTES		
Search Notes	Date	Examiner
EAST inventor name search	3/3/2008	HWB
Consulted with Examiner Alex Sofocleous	2/29/2008	HWB
Consulted with Primary Examiner Tuan Nguyen	3/3/2008	HWB
See attached EAST search	3/3/2008	HWB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
365	158, 171, 173, 189.01, 189.04, 189.14, 230.04, 243	3/3/2008	HWB
711	200, 202, 217, 218, 220	3/3/2008	HWB